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|-----------------------------------|--|-------------------------|---|--|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/601,420 | NEAU, DAVID MATTHEW | |
| Examiner | | Art Unit | Page 1 of 1 | |
| Alexandra Awai | | 3663 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------------|----------------|
| | A | US-6,169,776 B1 | 01-2001 | Collins, James Christopher | 376/249 |
| | B | US-4,585,610 | 04-1986 | Andersson et al. | 376/249 |
| | C | US-6,240,155 B1 | 05-2001 | Kurosawa et al. | 376/305 |
| | D | US-4,647,422 | 03-1987 | Altman, Denis J. | 376/260 |
| | E | US-5,305,361 | 04-1994 | Enomoto et al. | 376/316 |
| | F | US-5,844,956 | 12-1998 | Schramm et al. | 376/249 |
| | G | US-4,686,078 | 08-1987 | Zwart, Jr., Bernardus M. | 376/249 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | |
|---|---|
| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U |
| | V |
| | W |
| | X |

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